


<b>Search Notes</b>  	<b>Application/Control No.</b>  10532619	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN, ERNEST C.
	<b>Examiner</b>  Emmanuel Bayard	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	295, 262, 324, 265	3/30/08	EB

SEARCH NOTES		
Search Notes	Date	Examiner
East	3/30/08	EB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	295, 324	3/30/08	EB